

Product Qualification Package CGD1040Hi

1 GHz, 20dB gain GaAs high output power doubler

Rev. 01 — December 11, 2009

Document information

Info	Content
Keywords	Product Qualification Package
Abstract	This document presents the characteristics of CGD1040Hi power doubler CATV amplifier.

NXP Semiconductors **Product Qualification Package CGD1040Hi**

Revision history

Rev	Date	Description
01	20091011	Initial Release

Contact information

For additional information, please visit: <http://www.nxp.com>

For sales office addresses, please send an email to: salesaddresses@nxp.com

1. Device description

1.1 Introduction

NXP's CGD1040Hi power doubler has been designed for 1 GHz 'sustainable networks'. This high performance GaAs device provides extended bandwidth and higher data rates, giving you the increased network capacity to deliver high-end services like HDTV, VoIP and digital simulcasting.

The CGD1040Hi is primarily designed for use in fiber deep-optical-node applications (N+0/1/2).

Designed for durability and offering superior ruggedness, this 1 GHz solution offers an extended temperature range, high power overstress capabilities.

Features:

- High output power capability
- Excellent linearity
- Superior levels of ESD protection
- Extremely low noise
- Excellent return loss properties
- Gain compensation over temperature
- Rugged construction
- Unconditionally stable
- Thermally optimized design
- Compliant to Directive 2002/95/EC, regarding Restriction of the use of certain Hazardous Substances (RoHS)
- Integrated ring wave surge protection

1.2 Chemical content

For Chemical content information CGD1040Hi (SOT115), please follow link below:

http://www.nxp.com/search/chemical_content/

1.3 Mounting & soldering recommendations for CATV products

1.3.1 Mounting Recommendations

The heat sink mounting surface must be flat, free of burrs and oxidation and parallel to the mounting surface. The heat sink, mounting base and ground leads should be properly RF-grounded. Heat sink compound should be applied sparingly and evenly on the mounting base. When mounting CATV hybrid modules, the UNC screws must first be turned finger-tight. The screws should then be tightened to within the tolerance of 0.5 Nm minimum and 0.7 Nm maximum.

1.3.2 Soldering Recommendations

Leads may be plugged-in onto the corresponding sockets or soldered directly into the circuit for robustness and for better RF-connection. The latter is specifically recommended for products that use Sn-plated leads. Soldering may be done using soldering iron with a maximum temperature of 260 °C for not more than 3 seconds with a minimum lead length between the closest solder joints and the module of 3 mm.

1.3.3 General information

Table 1. Product

NXP Type	Device Type description	Package	Status	Order / 12NC
CGD1040Hi	1 GHz, 20dB Gain GaAs high output power doubler	SOT115J	Released	9340 639 49112

Table 2. Manufacturing locations

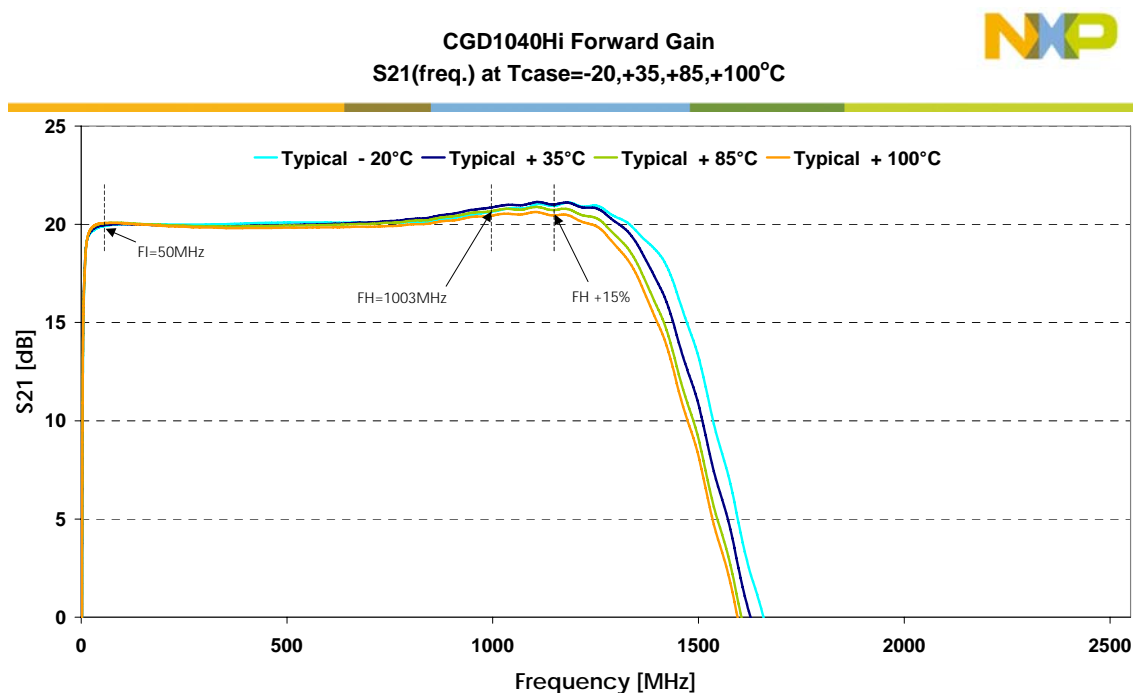
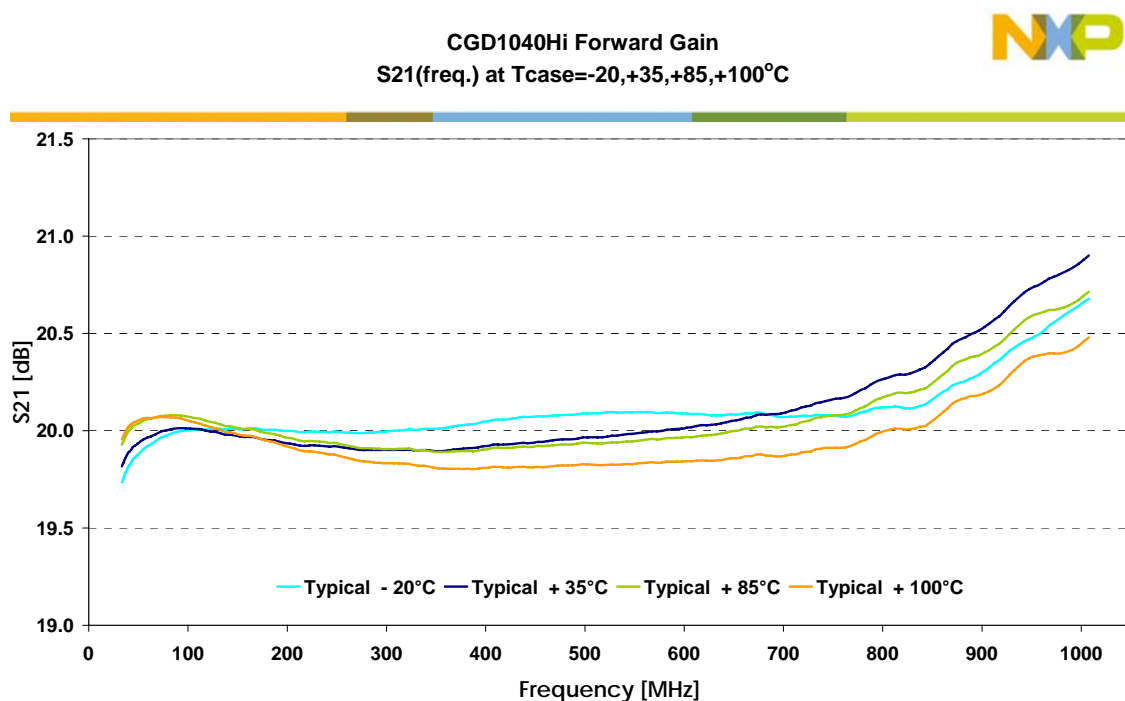
Sub assembly	Final Assembly & test
NXP Semiconductors (APK) *	NXP Semiconductors (APP3)*
* Certified ISO 14001 & ISO 9001	

Table 3. Package Technology

Package SOT115J	
Package Outline	<ul style="list-style-type: none"> - Rectangular single-ended package - Aluminium flange - 2 vertical mounting holes - 2 ' 6-32 UNC and 2 extra horizontal mounting holes - 7 gold-plated in-line leads

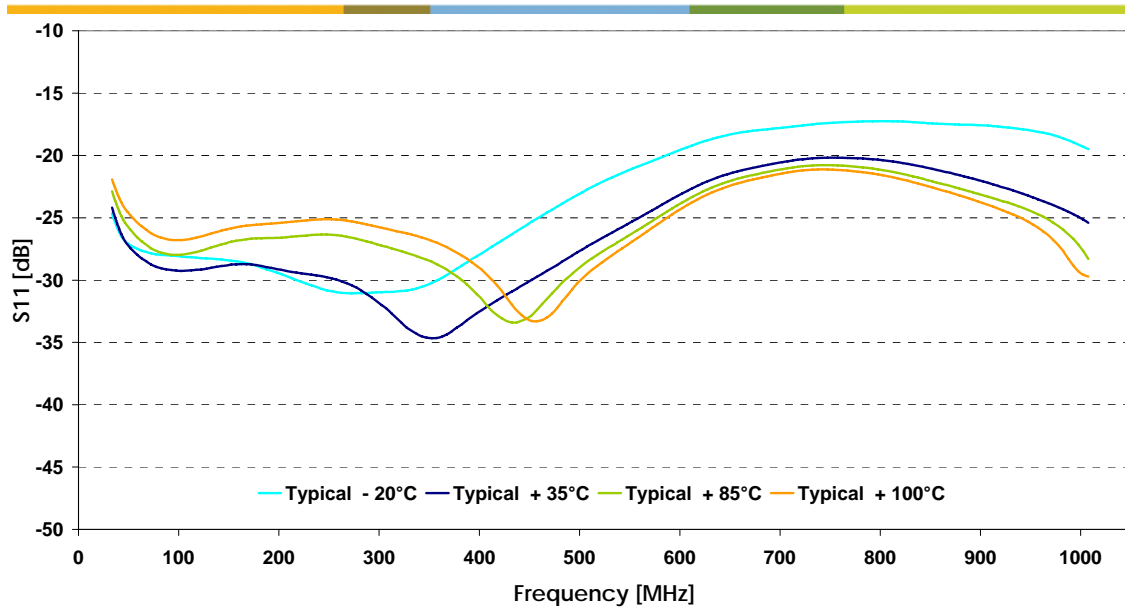
2. Characterization data

2.1 S-parameters and stability

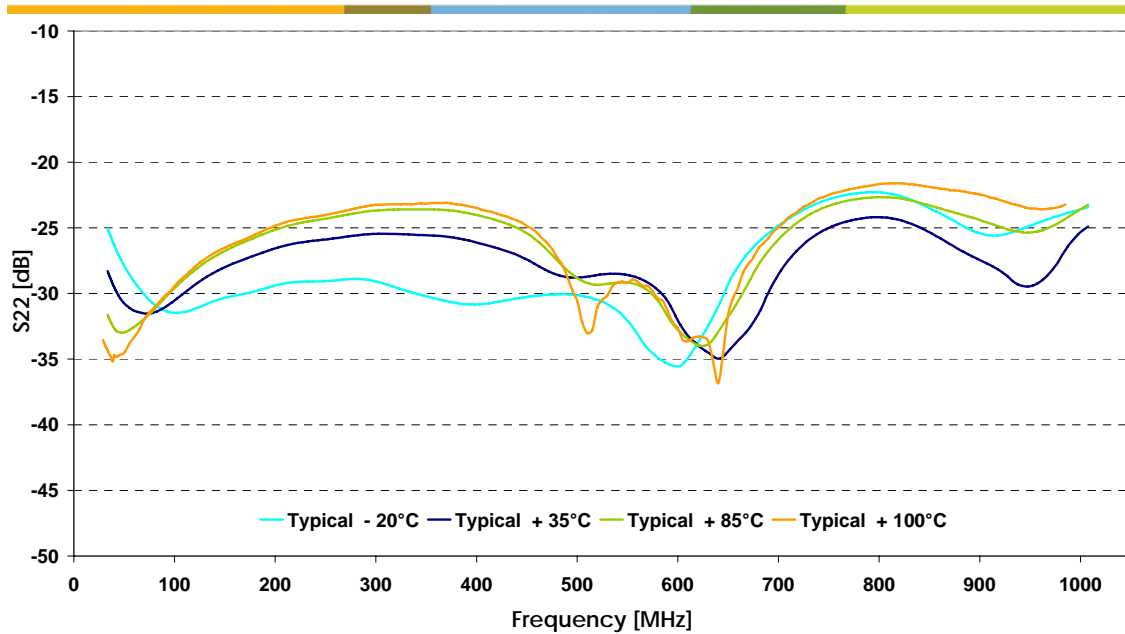


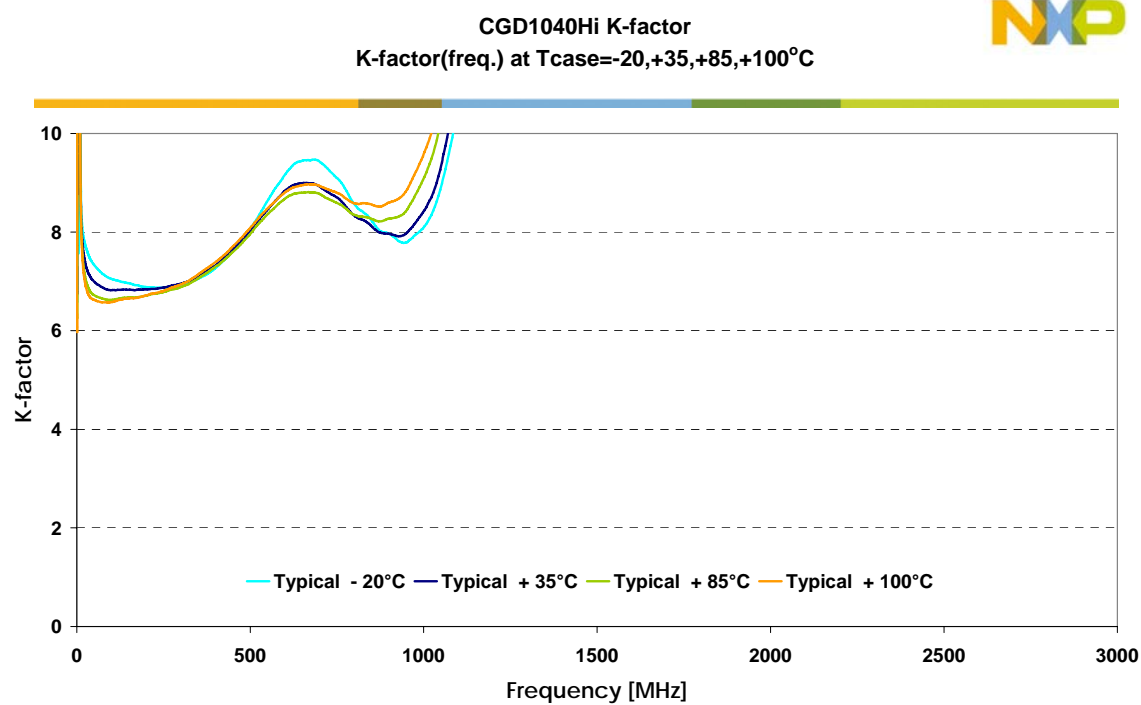
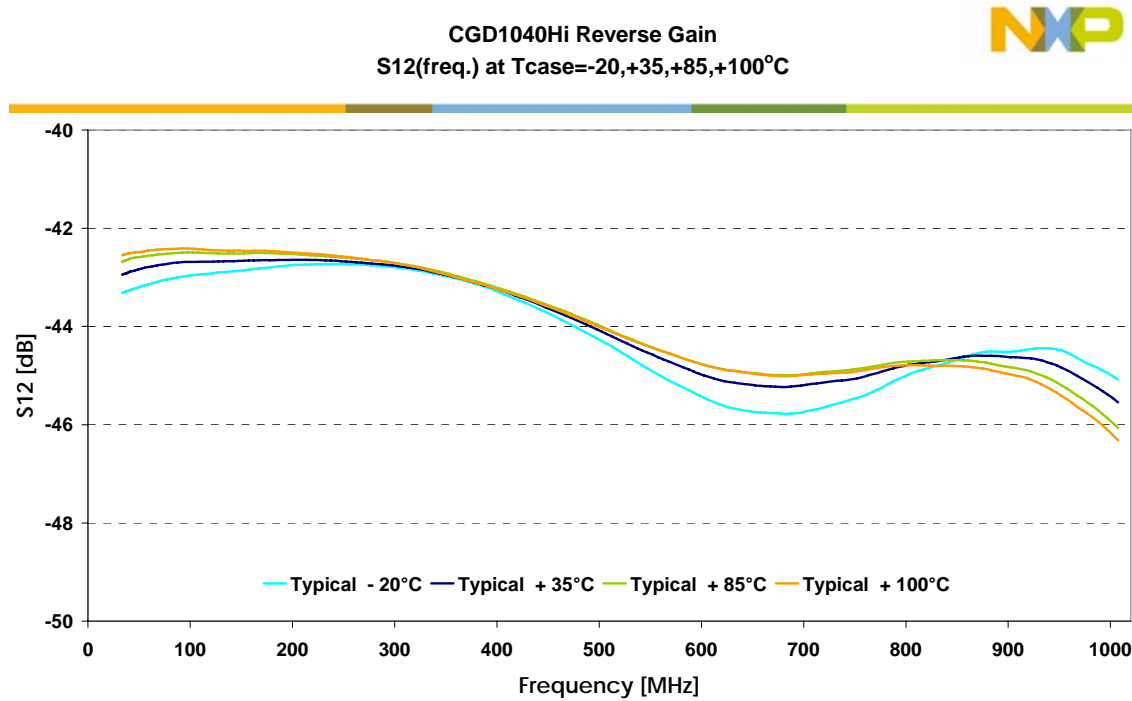


CGD1040Hi Input Return Loss
S11(freq.) at Tcase=-20,+35,+85,+100°C



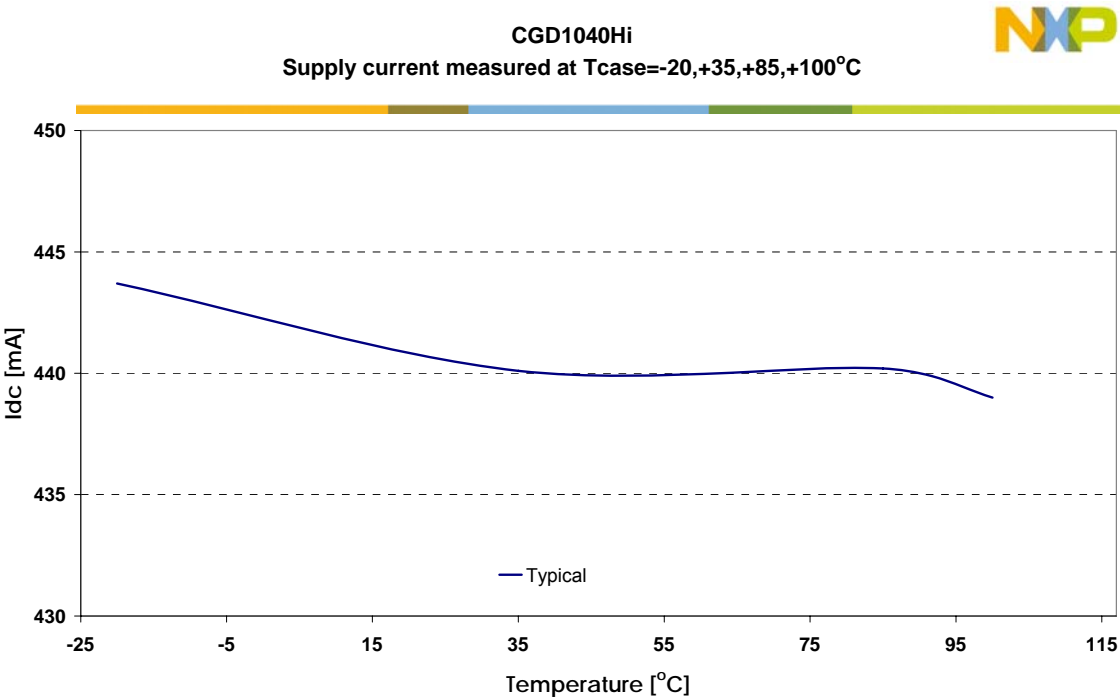
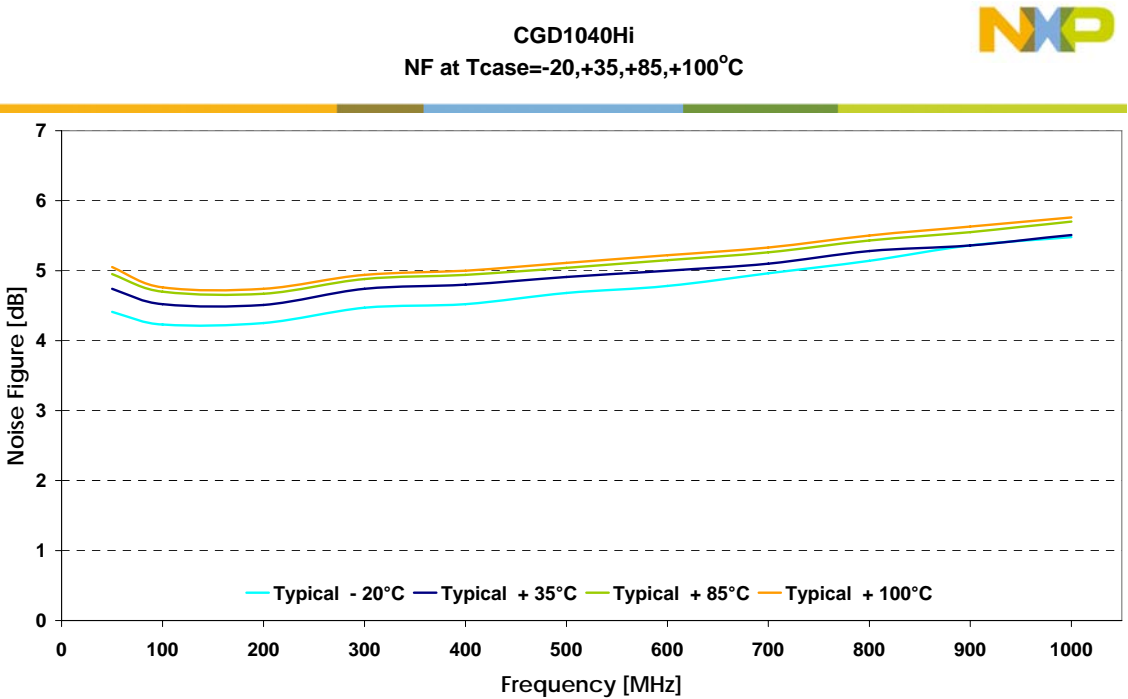
CGD1040Hi Output Return Loss
S22(freq.) at Tcase=-20,+35,+85,+100°C



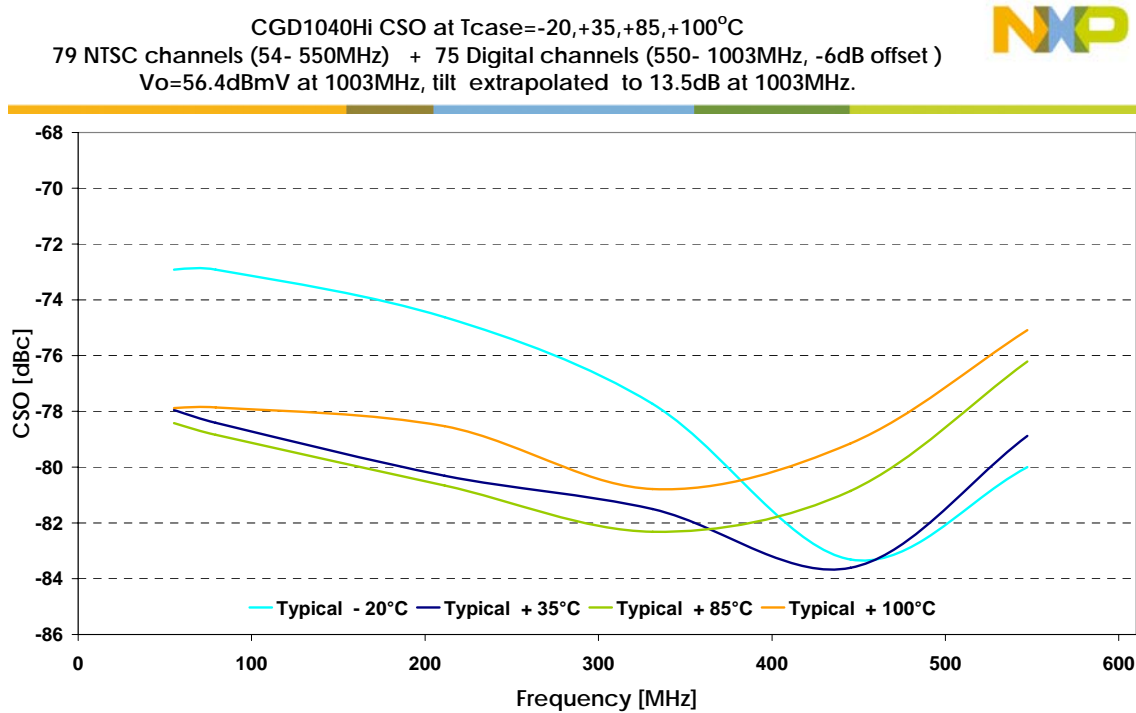
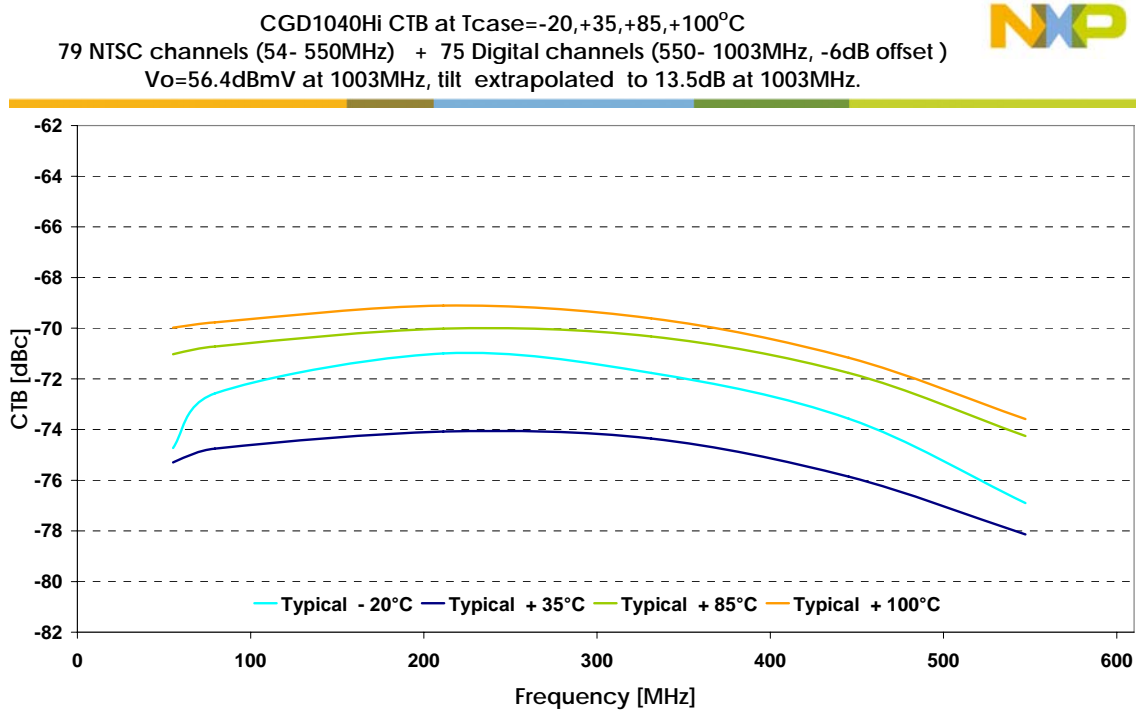


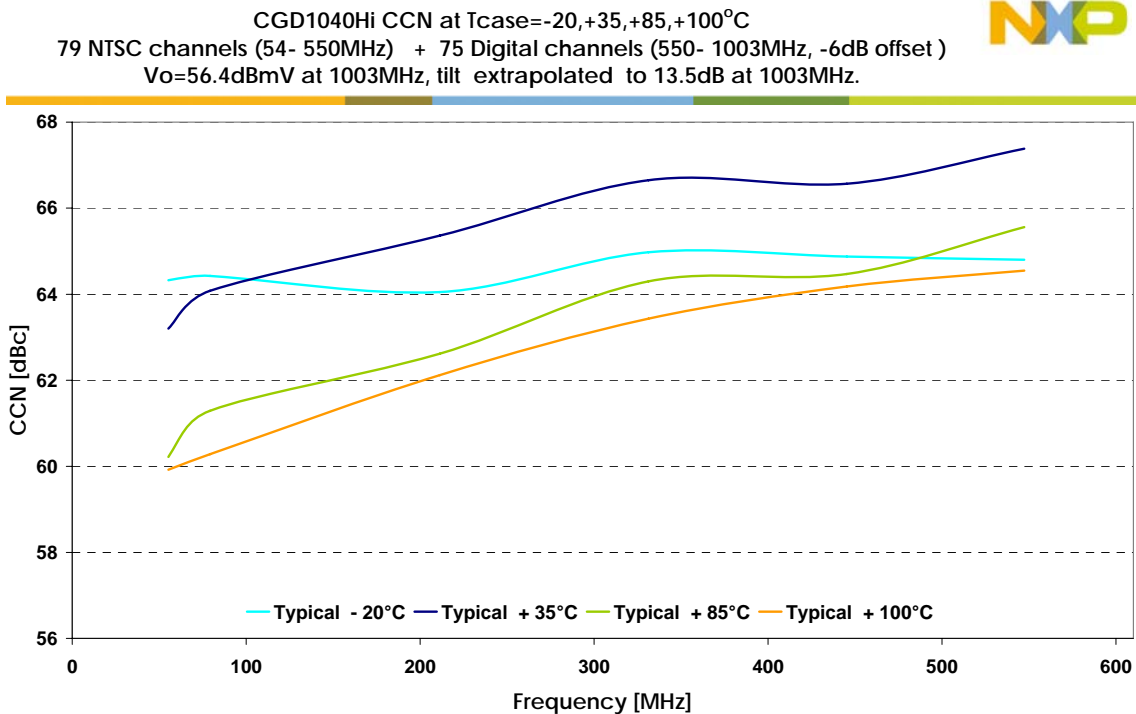
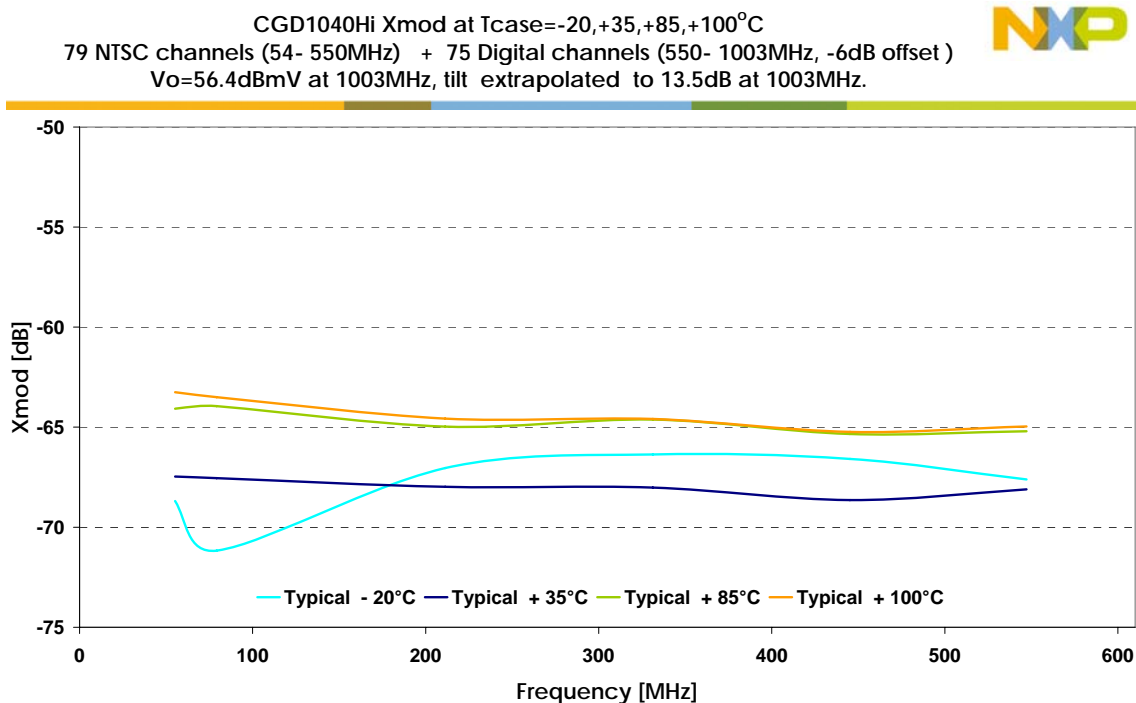
2.2 Noise

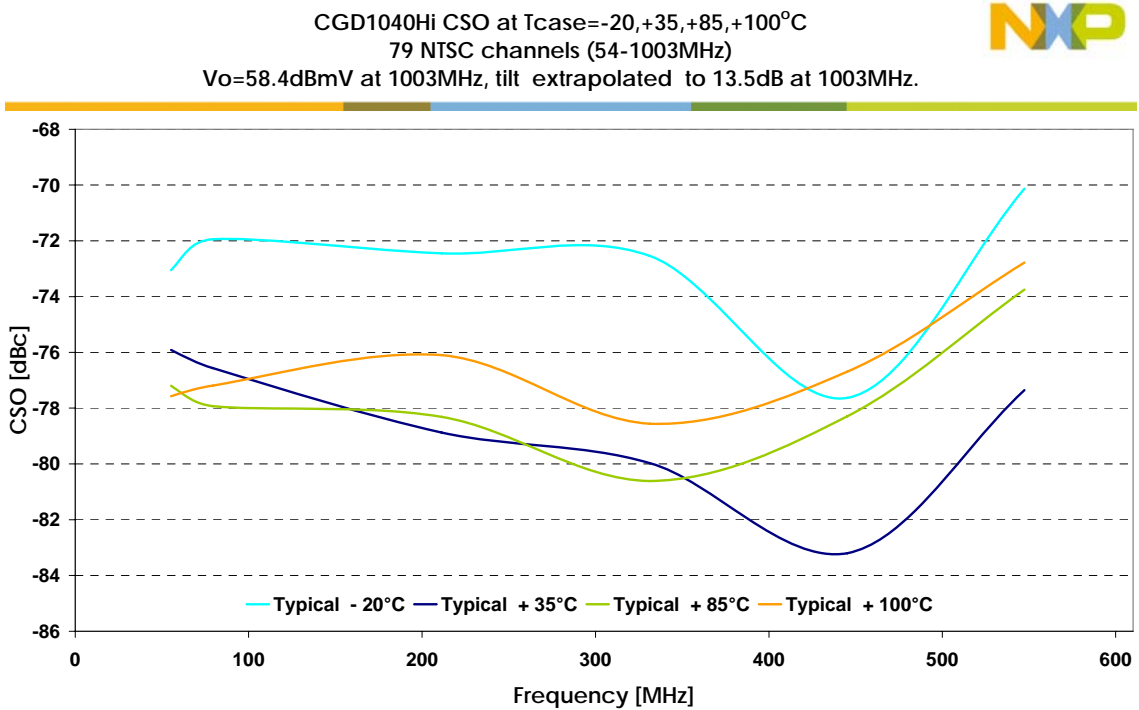
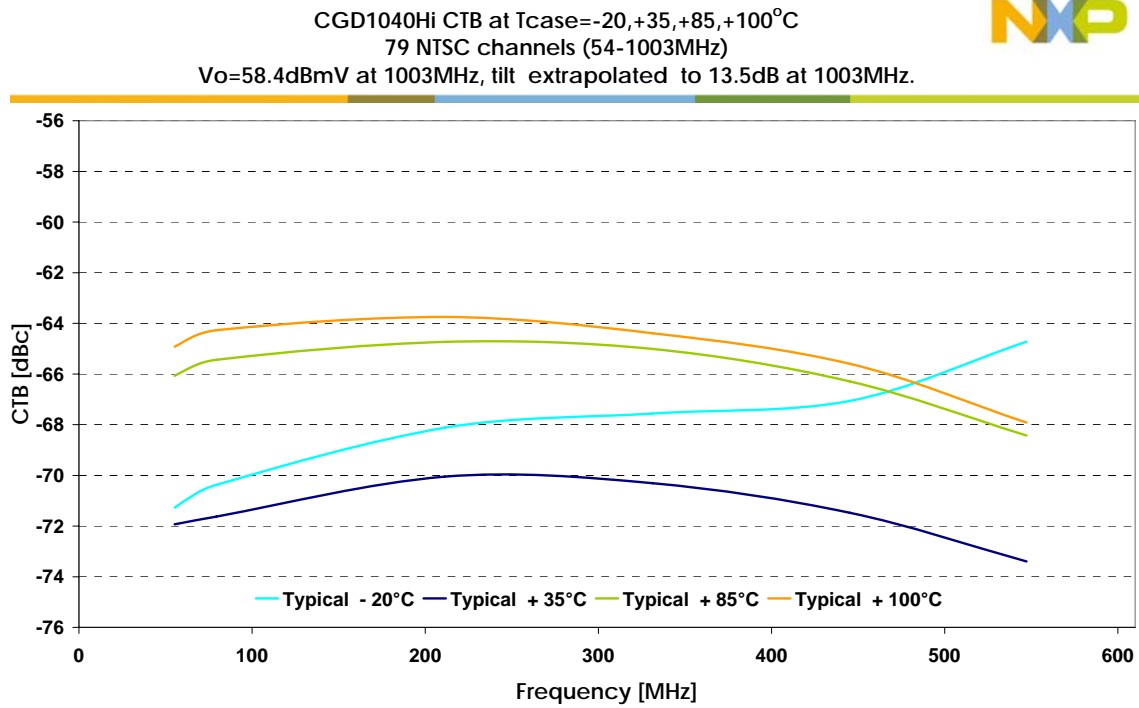
2.3 Supply current

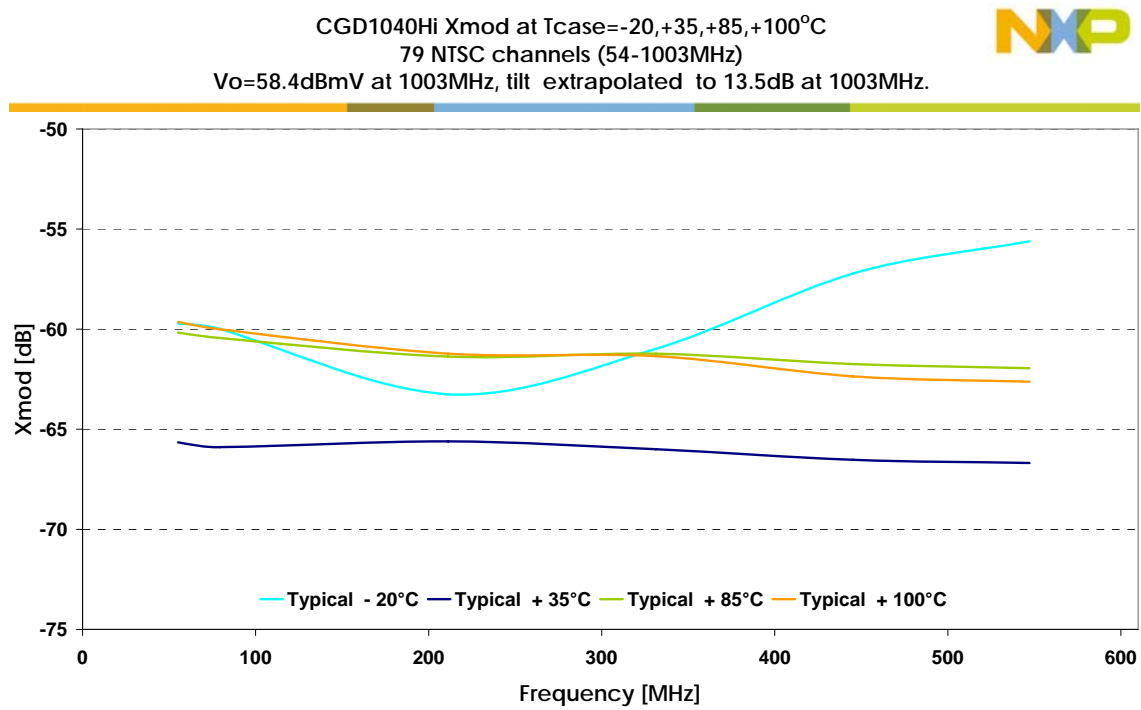


2.4 Distortion









2.5 Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
R _{th} (j-mb)	Thermal resistance from junction to mounting base	T _{mb} = 100°C +V _B = 24V I _{tot} = 448mA	4.5	K/W

3. Reliability results

NXP endurance tests are based on JEDEC and IEC standards.
Reliability testing applies the basic principle of structural similarity.

3.1 Environmental test results

Table 5. Environmental test overview

Test	Test Conditions	Duration	Sample size	Sample	Result
High Temperature Operating Life (HTOL)	$T_{mb} = 125^{\circ}\text{C}$, $V_{B+} = 27\text{V}$	1000 hrs	430	CGD1042H & CGD1044Hi (Structural similar)	PASS
Temperature Humidity (TH)	$T_a = 85^{\circ}\text{C}$ / RH = 85%	1000 hrs	15	CGD1042H (Structural similar)	PASS
Temperature Cycling (TMCL)	$T_a = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$	150 cycles	105	CGD1042H & CGD1044Hi (Structural similar)	PASS
Drop test (DT)	H = 1m	-	6	CGD1042 (Structural similar)	PASS
Highly Accelerated Stress Test (HAST)	$T_a = 130^{\circ}\text{C}$ / RH = 85%, $V_{B+} = 24\text{V}$	96 hrs	80	Sub-package (HVQFN)	PASS
High Temperature Storage Life (HTSL)	$T_a = 175^{\circ}\text{C}$	1000 hrs	150	Sub-package (HVQFN)	PASS
Temperature Cycling (TMCL)	$T_a = -65^{\circ}\text{C}$ to $+150^{\circ}\text{C}$	200 cycles	230	Sub-package (HVQFN)	PASS

* Sample size includes tested samples of all structural similar types

Table 6. Assessed Early Failure Rate

Life Test	Conditions	Early Failure Rate
HTOL	Confidence level: 60% T_{junc} ref: 55°C Sample size: 430	2130 FPM

Table 7. Assessed Intrinsic Failure Rate

Life Test	Conditions	Intrinsic Failure Rate
HTOL	Confidence level: 60% T _{junc} ref: 55°C Activation Energy: 0.7eV Acceleration factor determined according Arrhenius formula	4 FIT

3.2 Electrical Overstress

Table 8. Electrical Overstress results

Test	Test Conditions	Pass / Level
ESD (HBM)	Per JEDEC: JESD22-A114	2000V
ESD (Bias)	Per IEC61000-4-2	1500V
Surge pulse	Per IEC 1000-4-5: +V _B = 40V RF-in = 80V RF-out = 80V T _{mb} = 35°C	PASS
RF overload	V _{i(RF)} = 75 dBmV, single tone * Z _L = 0 - ∞ Ω T _{mb} = 35°C Full recovery after 1 hr under bias condition * At the most critical frequency within the operational pass band	PASS
DC supply over-voltage	Duration = 1 min. T _{mb} = 35°C	40V
Transient on top of DC supply	+V _B = 24V T _{mb} = 35°C Pulse width / frequency = 0.1ms/1500Hz 1.0ms/150Hz 10.0ms/15Hz 100.0ms/1.5Hz Number of pulses = 20	29V

4. ESD precaution

Introduction

This document is designed to help you gain a better understanding of semiconductor devices, so as to ensure the quality and reliability of the devices that you incorporate into your designs.

Electrostatic charge generation

In neutral material, the net charge of protons (positive charge) and electrons (negative charge) is zero. When the surface of one material is rubbed along that of another, local (frictional) heating can transfer energy to the electrons near the surface in excess of the Coulomb binding energy. Such electrons may leave their outer valence orbit and be trapped in an outer valence orbit in the other material. Thus two ions will be formed: 1) positive, for electron-donor material and 2) negative, for electron-acceptor material. Friction between any two surfaces involving at least one non-conductive material is a potential generator of electrostatic (triboelectric) charge; the magnitude and polarity of the charge depends on; the materials involved. Charge magnitude and polarity depends on the sum of the separations from the neutral boundary of the two materials in the triboelectric series (Table 1) frictional heat, which depends on speed and applied force surface conductivity. Part of the charge may be drained off during and after rubbing, inhibiting build up of maximum possible voltage, but this is true only for surface conductivities below $10E9$ per Surface Square.

A grounded operator cannot drain charge from a non-conductive object. Thus, an operator's clothing may be charged even though a conductive wrist strap grounds his body. Similarly, charged plastic boxes or trays will not be discharged by a grounded operator or bench top.

Induction

Static charges can be transferred by induction; that is, without direct contact. Objects that can transfer charges by induction include the plastic boxes, trays and covers used extensively in production lines. An ESD-sensitive device charged by induction can be damaged if touched by a grounded operator. Removing static charges from insulating materials can only be achieved by use of ionizers.

ESD precautions

In the following section are some hints to avoid ESD damage.

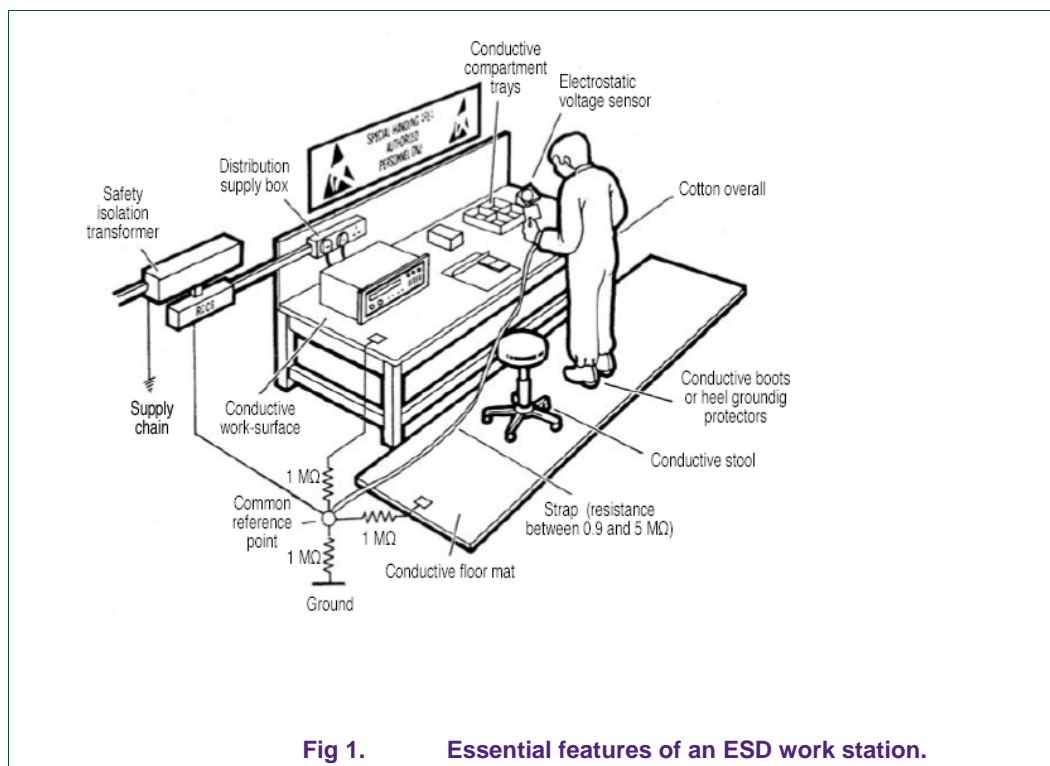
For more detailed information see JEDEC standard JESD625-A, which establishes the minimum requirements for Electrostatic Discharge (ESD) control methods and materials used to protect electronic devices that are susceptible to damage or degradation from electrostatic discharge (ESD).

The ESD workstation

Essential features of a workstation for handling ESD devices are shown in Fig. 1. Adaptations for inspection, assembly, repair and other purposes should respect these guidelines:

- Conductive work-surface sheet resistance $10\text{ K } \Omega$ to $1\text{ M } \Omega$ per square meter
- Resistor for grounding wrist strap between $0.9\text{M } \Omega$ and $5\text{M } \Omega$.
Maximum ground current 2 mA: enough for operator to feel a fault but well below danger level
- All test equipment grounded
- Switching transients suppressed
- All metal table trim, support frames and brackets grounded
- Cotton working garments

- Static-safe rails, bags, foam pads and shorting clips available, if needed.



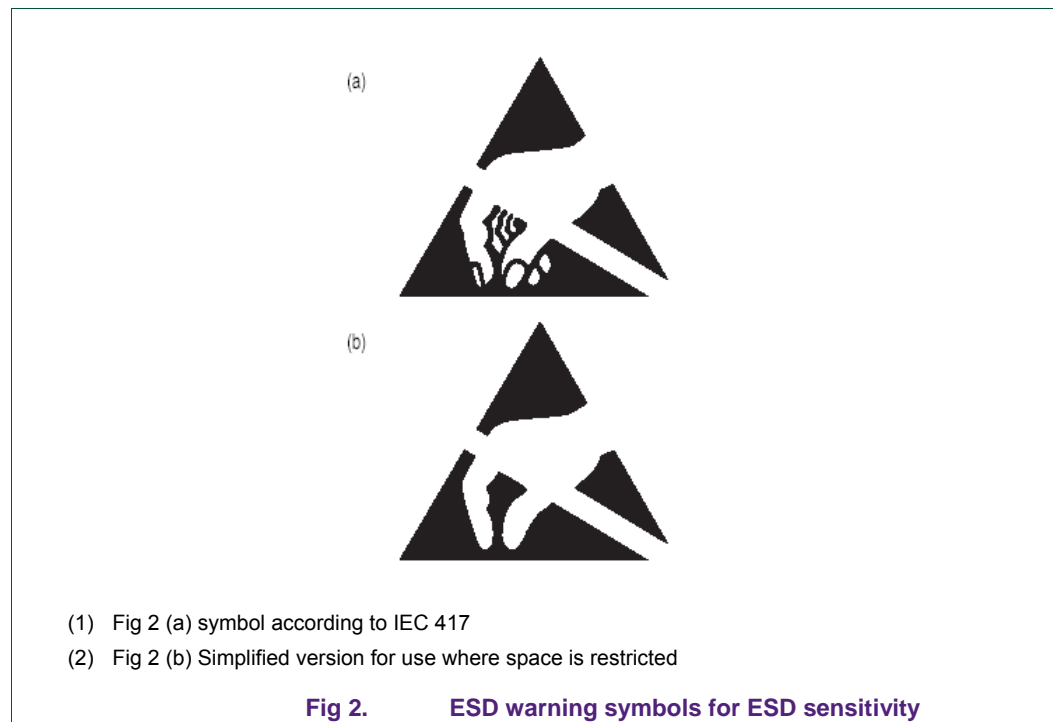
4.1 Circuit layout precautions

Designing of a circuit board for ESD-sensitive devices should allow for handling by persons unaware of the ESD hazard. Observe the following precautions:

- Tracks to and from ESD-sensitive devices should not pass board edges, to minimize the risk of their being touched in handling.
- Where possible, connect a resistor of about 1 MΩ between conductors from ESD-sensitive devices and board inputs and outputs.
- Avoid long signal lines; they increase the risk of induced large-signal pick-up.
- Observe the maximum rated values for supply turn-on and turn-off transients. Suppress power supply turn-on and turn-off transients, power supply ripple or regulation and ground noise, to avoid exceeding the Absolute Maximum ratings. Fast zener protection diodes are useful here.
- Label the board with an ESD warning.
- Make sure that the service documentation calls attention to the use of ESD-sensitive devices and the precautions to be taken with them.

Marking of ESD-sensitive devices

IEC 417 and MIL-STD-1686 recommend that the symbol shown in Fig. 2(a) is used to mark ESD sensitive devices. The symbol should be supplemented by the notice 'ATTENTION – observe precautions for handling ELECTROSTATIC SENSITIVE DEVICES'. Where space is restricted, the simplified symbol shown in Fig. 2(b) may be used. Symbol and lettering should be in black on a yellow ground.



User precautions

As a general rule, ESD-sensitive devices should always be handled at an ESD station conforming to Fig. 1. Pay particular attention to stores and inspection areas where personnel may not be fully aware of ESD hazards.

Packing and storage

ESD-sensitive devices are packed in antistatic or conductive boxes or rails. Intimate (tube, tape, bag etc.) and proximity (level 1 box) packing is marked with the Fig. 2 symbol. ESD-sensitive devices not supplied in antistatic packing should be returned to the supplier. ESD-sensitive devices should be stored in their original packing, preferably in a cool place set aside for the purpose. Do not unpack them until they are required for incoming inspection or use in production.

Receiving inspection

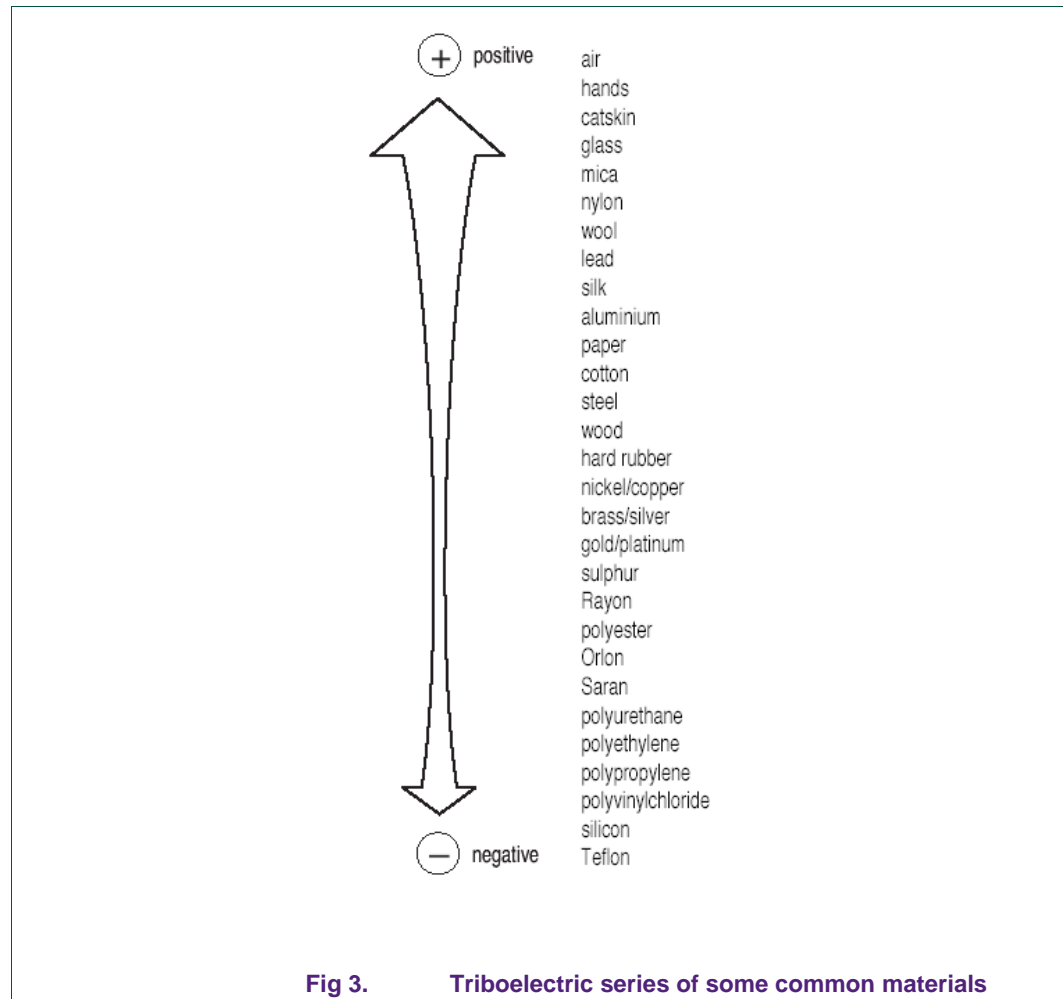
Do not put ESD-sensitive devices where static discharges can occur, even if they have protective packing. In their immediate vicinity avoid the presence of:

- Materials which can develop static charges (see Fig. 3)
- Electrical switching equipment and tools.

These precautions also apply to assemblies that incorporate ESD-sensitive devices.

Unpack and handle the devices at an ESD workstation generally conforming to Fig. 1. Take care that the devices are not exposed to the voltage pulses that can occur when switching the power supply on and off. Increase the supply voltage slowly to its normal value before applying test signals, to avoid the latching effect that occurs when the signal voltage exceeds the supply voltage. During testing, and especially when going from one test to another, ensure that all supplied voltages are under control. If possible, ground all unused inputs during tests. Do not allow a signal to remain on an input when the power supply is switched off. If necessary, connect a buffer stage between the signal source and the input in such a way that it automatically switches off the signal when the power supply is switched off.

After testing, repack the devices in their original anti-static packing; keeping the warning label intact. Repack at an ESD workstation.



Assembly precautions

ESD-sensitive devices should be the last components to be inserted in a circuit board or system.

Manual insertion: Use an ESD workstation.

Automatic insertion: Ground insertion equipment and machinery. Use only tools of conductive or antistatic material.

Use grounded component tongs to remove ESD sensitive devices from their antistatic packing. Do not remove more components at a time than are immediately required.

Ground the soldering iron or bath. Do not solder to circuits that are connected to a switched-on power supply. Ensure that every work surface on which a circuit board may be placed is provided with a conductive or anti-static sheet big enough to receive the whole board.

Handle boards that contain ESD-sensitive devices as single components. Pack them in antistatic or conductive packing. Label them with an ESD warning. Ground all handling personnel.

Measurement precautions

Place the board, soldered side down, on a conductive or antistatic foam pad to discharge any static electricity. Remove short-circuit clips. Handle the board only by its edges, remove it from the foam pad for testing. After testing, replace it on the foam pad for transport.

Repair and maintenance precautions

Switch off the equipment in which the board is incorporated before removing a board containing ESD-sensitive devices. For repair and maintenance use an ESD workstation arranged as shown in Fig. 1. Place the board on an antistatic foam pad. Observing the 'Assembly precautions', remove and replace the faulty device. After testing, replace the board in the equipment.

Static detection and prevention equipment

A wide range of commercial products is available to help detect static electricity, equip workstations and prevent ESD. They range from conductive bags, gloves, mats, foam, wrist straps and boxes, through to static voltmeters, ionizers and ESD simulators. Careful use of available products can help locate and prevent ESD hazards, and so improve quality wherever semiconductors are.

Limitations of anti-static agents

Anti-static agents – conductive sprays – are commonly used to protect against ESD. Although they do protect against charging by friction, they do not form an effective shield and therefore give no protection against charge induction. The only sure protection against charge induction is a Faraday cage shielding the protected object from all possible sources of induced charge.

5. Legal information

5.1 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

5.2 Disclaimers

General — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of a NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is for the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from national authorities.

6. Contents

1.	Device description	3
1.1	Introduction.....	3
1.2	Chemical content.....	3
1.3	Mounting & soldering recommendations for CATV products	3
1.3.1	Mounting Recommendations.....	3
1.3.2	Soldering Recommendations	3
1.3.3	General information.....	4
2.	Characterization data.....	5
2.1	S-parameters and stability.....	5
2.2	Noise	8
2.3	Supply current	8
2.4	Distortion	9
2.5	Thermal characteristics	12
3.	Reliability results.....	13
3.1	Environmental test results	13
3.2	Electrical Overstress	14
4.	ESD precaution.....	15
4.1	Circuit layout precautions	16
5.	Legal information	20
5.1	Definitions.....	20
5.2	Disclaimers.....	20
6.	Contents.....	21

Please be aware that important notices concerning this document and the product(s) described herein, have been included in the section 'Legal information'.



© NXP B.V. 2009. All rights reserved.

For more information, please visit: <http://www.nxp.com>
For sales office addresses, email to: salesaddresses@nxp.com

Date of release: December 11, 2009
Document identifier: PQP_CGD1040Hi